

20V, $3.2m\Omega$, 100A, Single N-Channel

1.Features

- ◆ 20V MOSFET technology
- ◆ Low on-state resistance
- Fast switching
- ♦ Vgs±12V

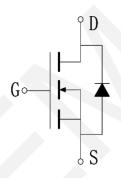
2.Ap	plica	ations
4 .7	PIICE	1110113

- ◆ Power Switching Application
- Load Switching



Pin Description

V _{DS}	R _{DS(on)} Typ.	I _D Max.	
20V	2.9mΩ @ 7.4V		
	3.2mΩ @ 4.5V	100A	
	3.7mΩ @ 2.5V		



Schematic Diagram

3.Absolute Max Ratings at Ta=25°C (Note1)

Parameter	Symbol	Maximum	Units
Drain to Source Voltage	V _{DSS}	20	V
Gate to Source Voltage	V _{GSS}	±12	V
Drain Current (DC)	I _D	100	Α
Drain Current (Pulse), PW≤300μs	I _{DP}	243	А
Total Dissipation	P _D	83	W
Avalanche Energy, Single Pulsed	E _{AS}	280	mJ
Junction Temperature	Tj	150	°C
Storage Temperature	T_{stg}	-55 to +150	°C

Note 1: Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

4. Thermal Resistance Ratings

Parameter	Symbol	Value	Unit
Junction to case	Rejc	1.8	°C/W

Note 2: When mounted on 1 inch square copper board $t \le 10$ sec The value in any given application depends on the user's specific board design.



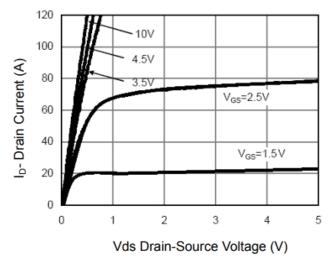
5.Electrical Characteristics at Ta=25°C (Note 3)

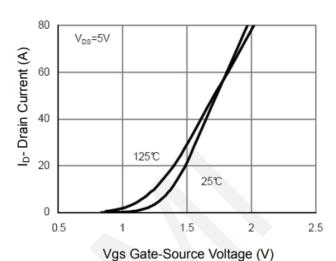
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Units
Drain to Source Breakdown Voltage	V _{(BR)DSS}	I _D = 250μA, V _{GS} = 0V	20			V
Zero-Gate Voltage Drain Current	I _{DSS}	V _{DS} = 20V, V _{GS} = 0V			1	μΑ
Gate to Source Leakage Current	I _{GSS}	$V_{GS} = \pm 12V, V_{DS} = 0V$			±100	nA
Gate Threshold Voltage	V _{GS(th)}	V _{DS} =V _{GS} , I _{DS} =250μA	0.5	0.75	1.2	V
	R _{DS(on)}	I _D = 30A, V _{GS} = 7.4V	-	2.9	3.7	mΩ
Static Drain to Source On-State Resistance		I _D = 20A, V _{GS} = 4.5V	-	3.2	3.9	mΩ
resistance		I _D = 20A, V _{GS} = 2.5V	-	3.7	6.1	mΩ
Forward Transconductance	G _{FS}	I _D = 20A, V _{DS} = 5V	20			S
Input Capacitance	C _{iss}	V _{GS} =0V, V _{DS} =10V,		2016		pF
Output Capacitance	Coss			391		pF
Reverse Transfer Capacitance	C _{rss}	Frequency=1.0MHz		130		pF
Turn-ON Delay Time	t _{d(on)}			6		ns
Rise Time	t _r	$V_{DD} = 10V, I_D = 20A,$ $V_{GS} = 10V,$ $R_{GEN} = 2.7\Omega$		4		ns
Turn-OFF Delay Time	t _{d(off)}			31		ns
Fall Time	t _f			5		ns
	Qg	V _{DS} = 10V,		15		nC
Total Gate Charge	Q _{gs}	$V_{GS} = 4.5V,$ $I_{D} = 20A$		3		nC
	Q_{gd}			4		nC
Diode Forward Voltage	V _{FSD}	I _S = 20A, V _{GS} = 0			1.2	V

Note 3: Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

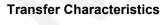


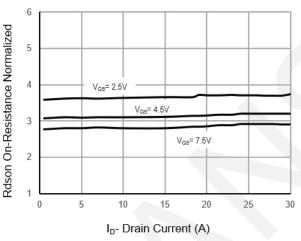
6. Typical electrical and thermal characteristics

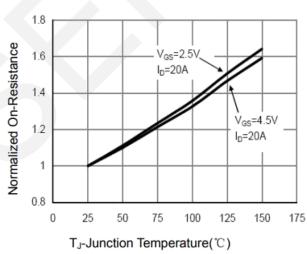




Output Characteristics

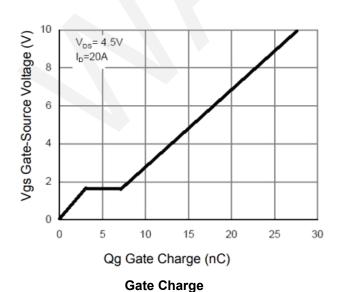


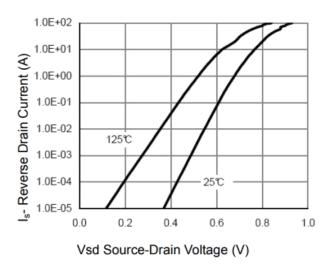




Rdson-Drain Current

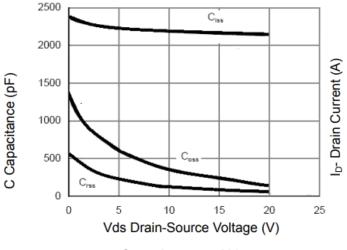
Rdson-Junction Temperature

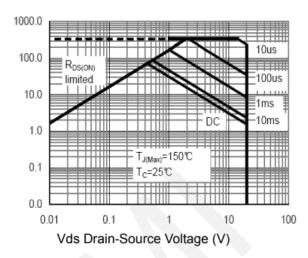




Source-Drain Diode Forward

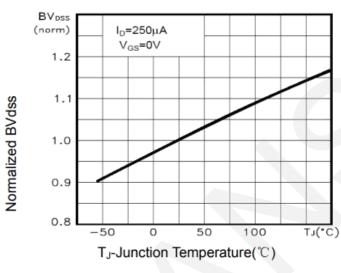


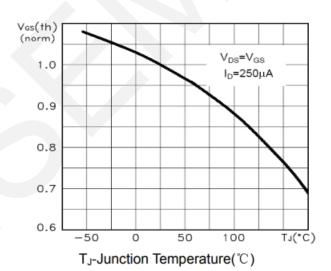




Capacitance vs Vds

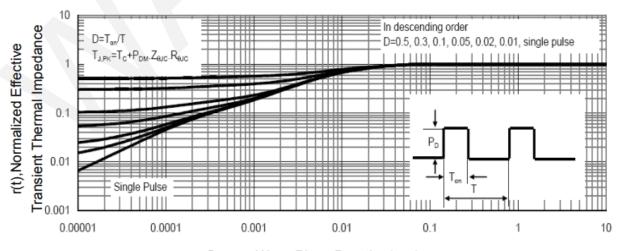
Safe Operation Area





BV_{DSS} vs Junction Temperature

V_{GS(th)} vs Junction Temperature

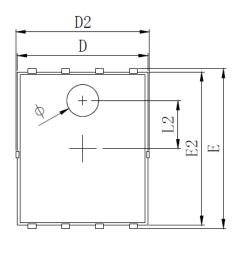


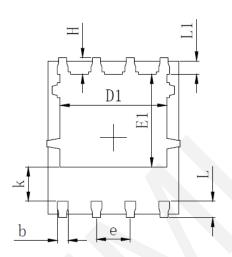
Square Wave Pluse Duration(sec)

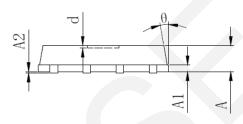
Normalized Maximum Transient Thermal Impedance



7.Package Dimensions







SYMBOL	MILLIMETER				
SIMDOL	MIN	Typ.	MAX		
A	0. 900	1.000	1. 100		
A1		0.254 REF.			
A2		0~0.05			
D	4. 824	4. 900	4. 976		
D1	3. 910	4. 010	4. 110		
D2	4. 924	5. 000	5. 076		
Е	5. 924	6. 000	6.076		
E1	3. 375	3. 475	3. 575		
E2	5. 674	5. 750	5. 826		
ь	0. 350	0. 400	0.450		
e	1.270 TYP.				
L	0. 534	0.610	0.686		
L1	0.424	0. 500	0. 576		
L2	1.800 REF.				
k	1. 190	1. 290	1. 390		
Н	0. 549	0. 625	0. 701		
θ	8°	10°	12°		
ф	1. 100	1. 200	1.300		
d			0. 100		



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